

# SANYO Semiconductors DATA SHEET

## LV5212VH — LED Driver Control IC

### Overview

The LV5212VH is a semiconductor integrated circuit that incorporates a serial input and serial or parallel output 8-stage shift register that features a CMOS structure based on Bi-CMOS process technology. The LV5212VH also contains an n-channel CMOS construction high-withstand-voltage, large-current drive 8-stage parallel output driver.

## Features

- Serial input and serial or parallel output
- Serial output enables cascade connection
- Serial input/output levels compatible with typical CMOS devices
- High-withstand-voltage LED driver with open drain output
  - High withstand voltage (VDS < 50V)
  - High-current drive (I $_{O}$  max = 300mA)
- Operating temperature range Ta = -25 to  $75^{\circ}C$

## **Specifications**

#### Maximum Ratings at $Ta = 25^{\circ}C$

•				
Parameter	Symbol	Conditions	Ratings	Unit
Maximum supply voltage	V <sub>CC</sub> max	sv <sub>CC</sub>	6	V
Output voltage	V <sub>O</sub> max	LEDO1 to LEDO8 off	50	V
Output current	I <sub>O</sub> max		300	mA
Allowable power dissipation	Pd max	Ta ≤ 25°C *	1000	mW
Operating temperature	Topr		-25 to +75	°C
Storage temperature	Tstg		-40 to +125	°C

\* Specified board : 114.3mm  $\times$  76.1mm  $\times$  1.6mm, glass epoxy board.

\* The device must be used within the ranges warranted for its specifications so as to ensure its specified ratings (such as maximum ratings and operating condition ranges) are not exceeded even momentarily.

Use of the device in such a way that its ratings are exceeded may cause failures, damage and other problems.

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- Enable input for output control
- Low supply current (0.0µA typ. during standby)

#### **Operating Conditions** at $Ta = 25^{\circ}C$

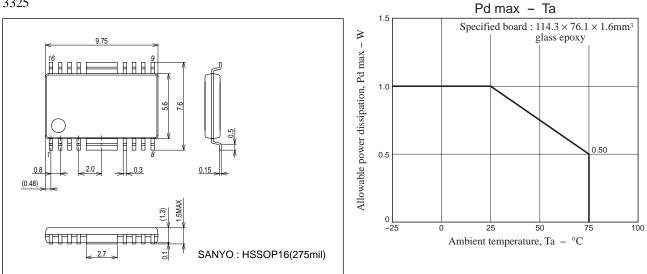
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Parameter	Symbol	Conditions	Ratings	Unit
Recommended supply voltage	VCC	sv <sub>CC</sub>	5.0	V
Operating supply voltage range	V <sub>CC</sub> op	sv <sub>CC</sub>	3.0 to 5.5	V
Output applied voltage	VO		50	V
Output current	I <sub>O</sub>	Duty = 45% to 55%	300	mA

## **Electrical Characteristics** at Ta = $25^{\circ}$ C, V<sub>CC</sub> = 5.0V

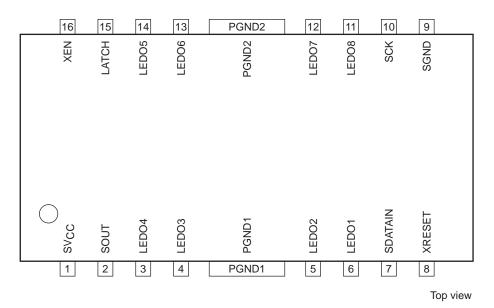
Parameter	Symbol	Conditions	Ratings			Unit
Parameter	Symbol	min	typ	max	Unit	
Quiescent current drain	ICC1	LEDO driver off (standby)		0	5	μΑ
LEDO output on resistance	Ron	I <sub>O</sub> = 100mA		3		Ω
OFF leak current	lleak	V <sub>O</sub> = 50V		0	10	μΑ
Control circuit block						
H level 1	V <sub>IN</sub> H1	Input H level	$V_{CC} \times 0.8$			V
L level 1	V <sub>IN</sub> L1	Input L level	0		$V_{CC} \times 0.2$	V
H level 2	V <sub>O</sub> UTH1	SOUT I <sub>O</sub> = -1mA	V <sub>CC</sub> -0.3			V
L level 2	V <sub>O</sub> UTL1	SOUT I <sub>O</sub> = 1mA	0		0.3	V

## Package Dimensions

unit : mm (typ) 3325



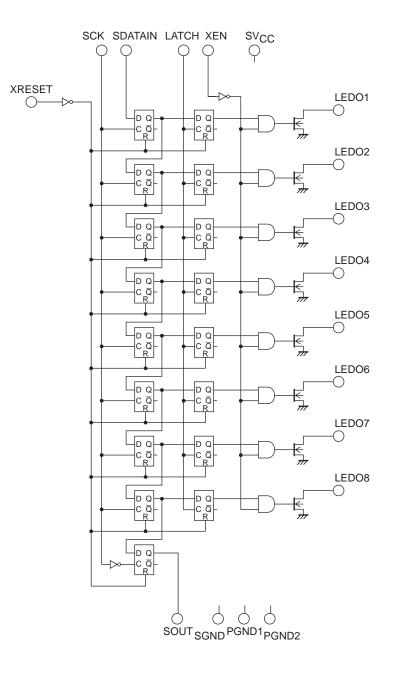
## Pin Assignment



## **Pin Descriptions**

Pin No.	- Pin name	I/O	Description
1	SV <sub>CC</sub>	1/0	Power supply
2	SOUT	0	shift register output (final-stage shift register)
		-	
3	LEDO4	0	LEDO4 Latch output (LEDO4 of shift register)
4	LEDO3	0	LEDO3 Latch output (LEDO3 of shift register)
5	LEDO2	0	LEDO2 Latch output (LEDO2 of shift register)
6	LEDO1	0	LEDO1 Latch output (LEDO1 of shift register)
7	SDATAIN	I	Serial input
8	XRESET	I	Reset input (shift register and latch)
9	SGND		GND
10	SCK	I	Clock input (for shift register)
11	LEDO8	0	LEDO8 Latch output (LEDO8 of shift register)
12	LEDO7	0	LEDO7 Latch output (LEDO7 of shift register)
13	LEDO6	0	LEDO6 Latch output (LEDO6 of shift register)
14	LEDO5	0	LEDO5 Latch output (LEDO5 of shift register)
15	LATCH	I	Latch input
			When the latch input is held low, the LED0 output status is retained.
			When a high-level is input, the LED0 outputs change when the status of the shift register changes.
16	XEN	I	Enable inputs (LEDO1 to LEDO8)
			When a high-level is input, all the LED0 outputs are turned off.
			When a low-level is input, the shift register data is output to LED0.
PGND1	PGND1		GND
PGND1	PGND2		GND

## **Block Diagram**



### **Function**

The LV5212VH consists of 1) an 8-stage D-type flip-flop and 2) an 8-stage D-type flip-flop connected to the output of 1). When data is supplied to the serial data input (SDATAIN) and the clock pulse is supplied to the clock input (SCK), the serial data input signal is input to the internal shift register and the data already in the shift register shifted sequentially when the clock changes from low to high.

The serial output (SOUT) is used to connect multiple LV5212VH to expand the number of bits and is connected to the SDATAIN of the next stage. (Cascade connection supported.)

For parallel output, when the output control enable input (XEN) is low, the latch input (LATCH) changes from low to high and the clock pulse input changes from low to high, the serial data input signal is output to LED01, and the output is shifted sequentially. For parallel outputs (LED2 to LED8), the signals whose polarities inverted from those of the serial data input (SDATAIN) are output.

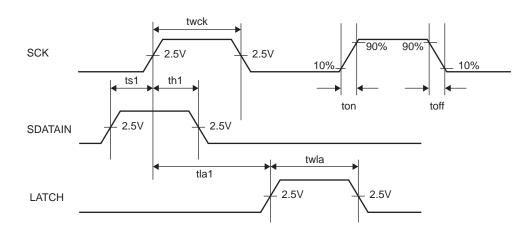
When the EN input is high, outputs LED01 through LED01 all turn off.

When the reset input is low, outputs LED01 through LED8 and SOUT outputs all turn off. The power must be turned on after checking that the reset input is low.

Pin Fu	Pin Functions							
Pin No.	Pin Name	Pin function	Equivalent Circuit					
7 10	SDATAIN SCK	Pull-down input	SGND					
8 15 16	XRESET LATCH XEN	Pull-up input	SGND					
2	SOUT	SOUT output	SVCC SOUT SOUT SGND					
3 4 5 6 11 12 13 14	LEDO4 LEDO2 LEDO1 LEDO8 LEDO7 LEDO6 LEDO5	LEDO outputs LEDO1 to LEDO8	SGND PGND					

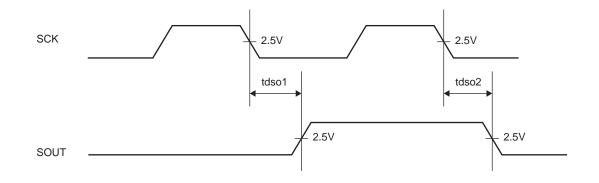
## **Timing conditions**

Parameter	symbol	Conditions	min	typ	max	unit
Clock frequency	fs1	SCK Duty = 50%			10	MHz
Clock pulse width	twck	SCK	50			ns
Latch pulse width	twla	LATCH	50			ns
Data set up time	ts1	SDATAIN setup time relative to the rise of SCK	25			ns
Data hold time	th1	SDATAIN data hold time relative to the rise of SCK	25			ns
Clock latch time	tla1		100			ns
Input conditions 1	ton	SCK and SDATAIN rise time			100	ns
Input conditions 2	toff	SCL and SDATAIN fall time			100	ns



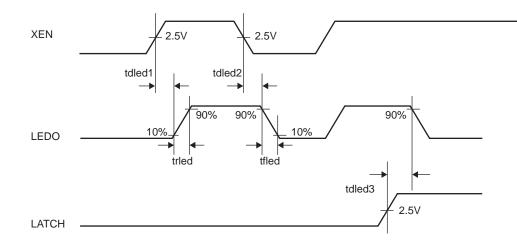
## SOUT output timings

Parameter	symbol	Conditions	min	typ	max	unit
SOUT delay time 1	tdso1	The time from a SCK falling edge to SOUT rising edge			50	MHz
SOUT delay time 2	tdso2	The time from a SCK falling edge to SOUT falling edge			50	ns



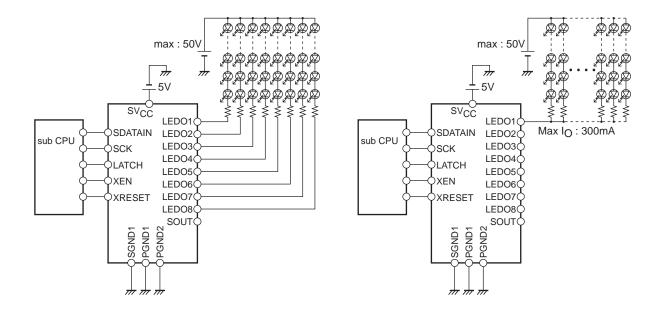
## LEDO output timings

Parameter	symbol	Conditions	min	typ	max	unit
LEDO delay time 1	tdled1	The time from an XEN rising edge to LEDO rising edge CL = 30pF, I_O = 100mA, V_O = 30V		100		ns
LEDO delay time 2	tdled2	The time from an XEN falling edge to LEDO falling edge CL = 30pF, I_O = 100mA, V_O = 30V		100		ns
LEDO rise time	trled	LEDO rise time CL = 30pF, I <sub>O</sub> = 100mA, V <sub>O</sub> = 30V		200		ns
LEDO fall time	tfled	LEDO fall time CL = 30pF, I <sub>O</sub> = 100mA, V <sub>O</sub> = 30V		200		ns
LEDO delay time 3	tdled3	The time from a LATCH rising edge to LEDO falling edge CL = 30pF, $I_O$ = 100mA, $V_O$ = 30V		200		ns

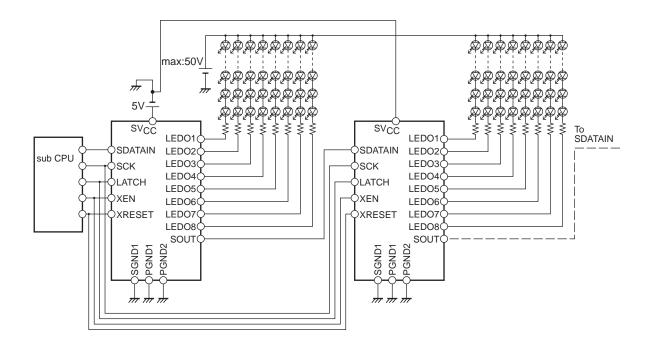


## **Application Circuit Example**

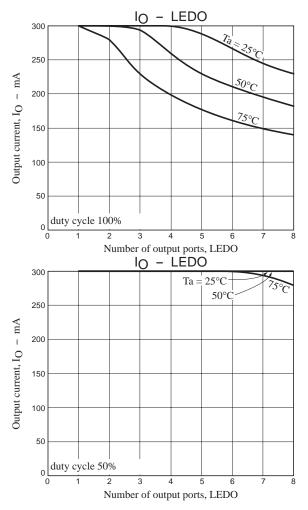
• When parallel output is used

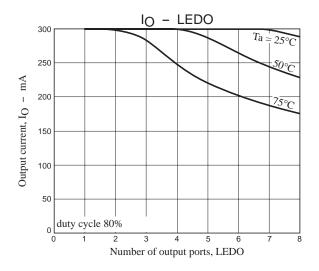


• When serial output is used (SOUT cascade connection)



#### Allowable output current characteristics





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